## Notice of References Cited Application/Control No. 10/792,004 Examiner Li Liu Applicant(s)/Patent Under Reexamination TIAN ET AL. Art Unit Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2004/0008931	01-2004	Bacque, James Benson	385/24
*	В	US-6,616,349	09-2003	Li et al.	398/4
*	С	US-6,895,186	05-2005	Stern, Thomas E.	398/83
*	D	US-6,061,157	05-2000	Terahara, Takafumi	398/1
*	E	US-7,120,359	10-2006	Way, Winston	398/59
*	F	US-6,208,443	03-2001	Liu et al.	398/9
*	G	US-2003/0025956	02-2003	Li et al.	359/110
	Н	US-			
	1	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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	R					
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	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	w	
	x	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.